| Notice of References Cited | Application/Control No. 10/681,050 | Applicant(s)/Patent Under Reexamination LEE, CHUNG KEE | |
|---|---|---|---|
| | Examiner Joseph A. Kaufman | Art Unit 3754 | Page 1 of 1 |

**U.S. PATENT DOCUMENTS**

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|---|---|---|---|
| * | A | US-3,865,313 | 02-1975 | Kondo, Hiroshi | 239/333 |
| * | B | US-4,516,727 | 05-1985 | Saito et al. | 239/333 |
| * | C | US-5,011,046 | 04-1991 | Graf et al. | 222/321.2 |
| * | D | US-5,083,682 | 01-1992 | Cater, Miro S. | 222/321.2 |
| * | E | US-5,337,926 | 08-1994 | Drobish et al. | 222/309 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

**FOREIGN PATENT DOCUMENTS**

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|---|---|---|---|---|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

**NON-PATENT DOCUMENTS**

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.